,		AU6	0 2 2004	30		Sheet	1 of	1 (0	3-02-04
	TO-1449	ATTY. DOCKET NO. 1190-0490P		APPLICATION OP/81					
. ]	INFORMATION D	ISCLO APPLI	CATION	ITATION I	APPLICANT Tomoaki IKEDA	et al			
	(Use several	f necessar	ry)	March 26, 2001	GROUP 2625				
			U	.S. PATENT D	OCUMENTS				
EKAMINER INITIAL	DOCUMENT NUM	BER	Kind	DATE	NAME	CLASS	CLASS	PILIN IP APP	G DATE ROPRIATE
h	US 5,635,985			06-03-1997	Boyce et al.	_			
in	US 5,812,200			09-22-1998	Normile	_			
In	US 6,023,553			02-08-2000	Boyce et al.				
	us us					R	ECE	IVE	Ð
	us					_	AUG 0	0.2004	
<u> </u>	US					1	AUS U	3 7004	
-	US					Tec	nology	Center	2600
	us					1			
	us								
			FOR	EIGN PATENT	DOCUMENTS				
	Office DOCUMENT		Kind	DATE	COUNTRY	CLASS	SUB CLASS	TRANS	LATION
	NUMBI	ER		······································		_		YES	МО
	ļ					· · · · · · · · · · · · · · · · · · ·	ļ		
ļ						-			
<u> </u>									
							<u> </u>		
	ļ					<del></del>	<del> </del>		
<u> </u>				· · · · · · · · · · · · · · · · · · ·		-			-
L	-				<u> </u>	<del> </del>	<u> </u>		
OTHER	R DOCUMENTS (In risk, symposium, catalog, et	clude Name	of the autho	or (in CAPITAL LETTERS), (	title of the article (when approisher, city and/or country where	priate), tit	le of the ite	ma (book, z	nagazine,
In	SHAPIRO, Jerome Very Low Bit Ra Apr. 27-30, 199	e M., A ate Ima 93 Proc	Applicat age Codi ceedings	ion of the Emb ng, Statistica of the Intern	edded Wavelet Hier l Signal and Array ational Conference , US, vol. 4, 27 A	archica Proces on Aco	sing, Mi ustics,	nneapo Speecl	olis, h and

EXAMINES: Initial if citation considered, whether or not citation is in conformance with N.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

DATE CONSIDERED . 10 . 05

EXAMINER